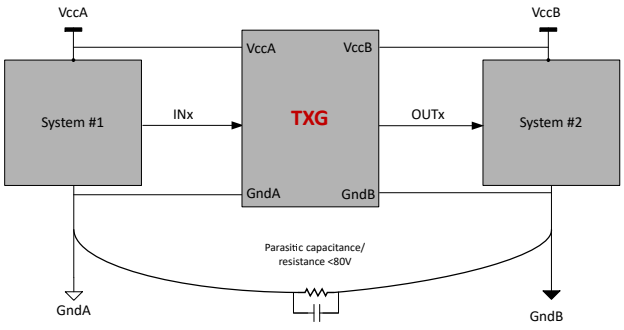
TXG802x-Q1 2-bit, ±80V Ground-Level Translator

1 Features

- AEC-Q100 qualified for automotive applications
- Supports DC shifts up to ±80V
- AC Noise Rejection of 140V_{PP} up to 1MHz
- CMTI of 250V/µs
- Low Prop Delay (<5ns) and Ch-Ch Skew (<0.20ns)
- Greater than 250Mbps
- Low power consumption (0.8mA per channel at 1Mbps, 1.8V)
- Fully configurable dual-rail design allows each port to operate from 1.71V to 5.5V
- 4, 2, 1 channel devices with multiple configurations will be available
- Two device variants:
  - TXG8020-Q1: 2 forward
  - TXG8021-Q1: 1 forward, 1 reverse
- Supports V_{CC} disconnect feature (I/Os are forced into high-Z)
- Schmitt-trigger inputs allows for slow and noisy signals
- Inputs with integrated static pull-down resistors prevent channels from floating
- Operating temperature from –40°C to +125°C
- Latch-up performance exceeds 100mA per JESD 78, class II
  - ESD protection exceeds JESD 22
  - 4000V human-body model
  - 500V charged-device model
- Package options provided:
  - DSG (WSON-8)
  - DDF (SOT-8)
  - D (SOIC-8)



Simplified Diagram

2 Applications

- Electric Power Steering
- Vehicle Control Unit
- Automotive Display
- Head Unit and Digital Cockpit

3 Description

The TXG802x-Q1 is a 2-bit, fixed direction, non-galvanic based voltage and ground-level translator that can support both logic-level shifting between 1.71V to 5.5V and ground-level shifting up to ±80V. Compared to traditional level shifters, the TXG802x-Q1 family can solve the challenges of voltage translation across different ground levels. The Simplified Diagram shows a common use case where DC shift occurs between GNDA to GNDB due to parasitic resistance or capacitance.

V_{CCA} is referenced to GNDA and V_{CCB} is referenced to GNDB. Ax pins are referenced to V_{CCA} logic level while Bx pins are referenced to V_{CCB} logic levels. Both A port and B port can accept voltages from 1.71V to 5.5V. The leakage between GNDA and GNDB is <2µA when V_{CC} to GND is shorted.

The TXG802x-Q1 device helps improve noise immunity and power sequencing across different ground domains while providing low power consumption, latency and channel-to-channel skew. It can supress noise levels of 140V_{PP} up to 1MHz (Figure 7-4). This device can support multiple interfaces such as UART, GPIO, and JTAG.

Package Information

PART NUMBER	PACKAGE (1)	BODY SIZE (NOM)
TXG8020-Q1 TXG8021-Q1	DSG (WSON-8)	2.0mm × 2.00mm
	DDF (SOT-8)	2.90mm × 1.60mm
	D (SOIC-8)	4.90mm × 3.90mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

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4 Pin Configuration and Functions

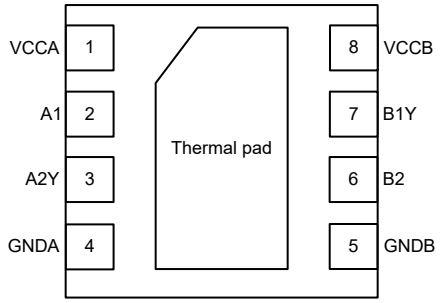

Figure 4-1. TXGx021DSG Package 8-Pin WSON Top View

Table 4-1. TXGx021 DSG Pin Functions

PIN		I/O	DESCRIPTION
Name	TXGx021		
A1	2	I	Input A1. Referenced to V_{CCA}
A2Y	3	O	Output A2. Referenced to V_{CCA}
B1Y	7	O	Output B1. Referenced to V_{CCB}
B2	6	I	Input B2. Referenced to V_{CCB}
V_{CCA}	1	—	A side supply voltage. 1.71V ≤ V_{CCA} ≤ 5.5V
V_{CCB}	8	—	B side supply voltage. 1.71V ≤ V_{CCB} ≤ 5.5V
GNDA	4	—	Ground reference for V_{CCA}
GNDB	5	—	Ground reference for V_{CCB}
—	Thermal pad	—	Keep thermal pad floating.

ADVANCE INFORMATION

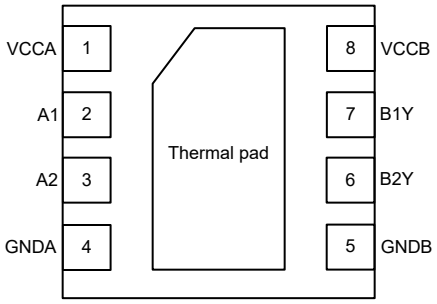

Figure 4-2. TXGx020DSG Package 8-Pin WSON Top View

Table 4-2. TXGx020 DSG Pin Functions

PIN		I/O	DESCRIPTION
Name	TXGx020		
A1	2	I	Input A1. Referenced to V_{CCA}
A2	3	I	Input A2. Referenced to V_{CCA}
B1Y	7	O	Output B1. Referenced to V_{CCB}
B2Y	6	O	Output B2. Referenced to V_{CCB}
V_{CCA}	1	—	A side supply voltage. 1.71V ≤ V_{CCA} ≤ 5.5V
V_{CCB}	8	—	B side supply voltage. 1.71V ≤ V_{CCB} ≤ 5.5V
GNDA	4	—	Ground reference for V_{CCA}
GNDB	5	—	Ground reference for V_{CCB}
—	Thermal pad	—	Keep thermal pad floating.

ADVANCE INFORMATION

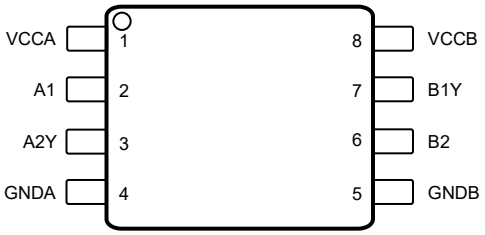

Figure 4-3. TXGx021DDF 8-Pin SOT and TXGx021D 8-pin SOIC Top View

Table 4-3. TXGx021 DDF and D Pin Functions

PIN		I/O	DESCRIPTION
Name	TXGx021		
A1	2	I	Input A1. Referenced to V_{CCA}
A2Y	3	O	Output A2. Referenced to V_{CCA}
B1Y	7	O	Output B1. Referenced to V_{CCB}
B2	6	I	Input B2. Referenced to V_{CCB}
V_{CCA}	1	—	A side supply voltage. 1.71V ≤ V_{CCA} ≤ 5.5V
V_{CCB}	8	—	B side supply voltage. 1.71V ≤ V_{CCB} ≤ 5.5V
GNDA	4	—	Ground reference for V_{CCA}
GNDB	5	—	Ground reference for V_{CCB}

ADVANCE INFORMATION

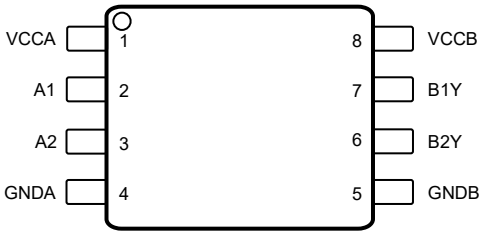

Figure 4-4. TXGx020DDF 8-Pin SOT and TXGx020D 8-pin SOIC Top View

Table 4-4. TXGx020 DDF and D Pin Functions

PIN		I/O	DESCRIPTION
Name	TXGx020		
A1	2	I	Input A1. Referenced to V_{CCA}
A2	3	I	Input A2. Referenced to V_{CCA}
B1Y	7	O	Output B1. Referenced to V_{CCB}
B2Y	6	O	Output B2. Referenced to V_{CCB}
V_{CCA}	1	—	A side supply voltage. 1.71V ≤ V_{CCA} ≤ 5.5V
V_{CCB}	8	—	B side supply voltage. 1.71V ≤ V_{CCB} ≤ 5.5V
GNDA	4	—	Ground reference for V_{CCA}
GNDB	5	—	Ground reference for V_{CCB}

ADVANCE INFORMATION

5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
V_{CCA} to V_{GNDA}	Supply voltage A to Ground voltage A		–0.5	6.5	V
V_{CCB} to V_{GNDB}	Supply voltage B to Ground voltage B		–0.5	6.5	V
V_{GNDA} to V_{GNDB}	Voltage between GNDA and GNDB	Voltage between GNDA and GNDB	-82	82	V
V_I	Input Voltage(2)	I/O Ports (A Port) to V_{GNDA}	–0.5	6.5	V
		I/O Ports (B Port) to V_{GNDB}	–0.5	6.5	
V_I	Input Voltage(2)	OE	–0.5	6.5	V
V_O	Voltage applied to any output in the high-impedance or power-off state(2)	A Port to V_{GNDA}	–0.5	6.5	V
		B Port to V_{GNDB}	–0.5	6.5	
V_O	Voltage applied to any output in the high or low state(2) (3)	A Port to V_{GNDA}	–0.5	V_{CCA} + 0.5	V
		B Port to V_{GNDB}	–0.5	V_{CCB} + 0.5	
I_{IK}	Input clamp current	V_I < 0	–20		mA
I_{OK}	Output clamp current	V_O < 0	–20		mA
I_O	Continuous output current		–25	25	mA
	Continuous current through V_{CC} or GND		–100	100	mA
T_j	Junction Temperature			150	°C
T_{stg}	Storage temperature		–65	150	°C

(1) Stresses beyond those listed under *Section 5.1* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Section 5.3* Exposure beyond the limits listed in *Section 5.3* may affect device reliability.
(2) The input voltage and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.
(3) The output positive-voltage rating may be exceeded up to 6.5V maximum if the output current rating is observed.

5.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001(1)	±2500	V
		Charged device model (CDM), per ANSI/ESDA/JEDEC JS-002(2)	±500	

(1) JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process.

ADVANCE INFORMATION

5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted) (1) (2) (3)

			MIN	TYP	MAX	UNIT
V_{CCA}	Supply voltage A - Relative to GNDA		1.71		5.5	V
V_{CCB}	Supply voltage B - Relative to GNDB		1.71		5.5	V
V_{GNDA} to V_{GNDB}	Voltage between GNDA and GNDB		-80		80	V
I_{OH}	High-level output current	V_{CCO} = 1.71V	–4.5			mA
		V_{CCO} = 2.3V	–8			
		V_{CCO} = 3V	–10			
		V_{CCO} = 4.5V	–12			
I_{OL}	Low-level output current	V_{CCO} = 1.71V			4.5	mA
		V_{CCO} = 2.3V			8	
		V_{CCO} = 3V			10	
		V_{CCO} = 4.5V			12	
V_I	Input voltage - Relative to GNDA		0		5.5	V
V_O	Output voltage - Relative to GNDB		0		V_{CCO}	V
T_A	Operating free-air temperature		–40		125	°C

(1) V_{CCI} is the V_{CC} associated with the input port.
(2) V_{CCO} is the V_{CC} associated with the output port.
(3) All control inputs and data I/Os of this device have weak pulldowns to ensure the line is not floating when undefined external to the device. The input leakage from these weak pulldowns is defined by the I_I specification indicated under Section 5.4.

ADVANCE INFORMATION

5.4 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)(1) (2)

PARAMETER		TEST CONDITIONS	V_{CCA}	V_{CCB}	Operating free-air temperature (T_A)			UNIT
					–40°C to 125°C			
					MIN	TYP	MAX	
V_{OH}	High-level output voltage (3)	I_{OH} = –4.5mA	1.71V	1.71V	1.5			V
		I_{OH} = –8mA	2.3V	2.3V	2.0			
		I_{OH} = –10mA	3V	3V	2.7			
		I_{OH} = –12mA	4.5V	4.5V	4.1			
V_{OL}	Low-level output voltage (4)	I_{OL} = 4.5mA	1.71V	1.71V			0.16	V
		I_{OL} = 8mA	2.3V	2.3V			0.27	
		I_{OL} = 10mA	3V	3V			0.34	
		I_{OL} = 12mA	4.5V	4.5V			0.41	
V_{T+}	Positive-going input-threshold voltage	Data Inputs (Ax, Bx) (Referenced to V_{CCI})	1.71V	1.71V			1.11	V
			2.3V	2.3V			1.40	
			3V	3V			1.73	
			4.5V	4.5V			2.45	
			5.5V	5.5V			3.0	
V_{T-}	Negative-going input-threshold voltage	Data Inputs (Ax, Bx) (Referenced to V_{CCI})	1.71V	1.71V	0.56			V
			2.3V	2.3V	0.80			
			3V	3V	1.15			
			4.5V	4.5V	1.59			
			5.5V	5.5V	2.0			
ΔV_T	Input-threshold hysteresis ($V_{T+} – V_{T-}$)	Data Inputs (Ax, Bx) (Referenced to V_{CCI})	1.71V	1.71V	0.3		0.55	V
			2.3V	2.3V	0.36		0.60	
			3V	3V	0.38		0.54	
			4.5V	4.5V	0.41		0.86	V
ΔV_T	Input-threshold hysteresis ($V_{T+} – V_{T-}$)	Data Inputs (Ax, Bx) (Referenced to V_{CCI})	5.5V	5.5V	0.40		0.96	V
I_I	Input leakage current	Data Inputs (Ax, Bx) V_I = V_{CCI} or GND	1.71V – 5.5V	1.71V – 5.5V	0.2		1.6	µA
$I_{off-float}$	Floating supply Partial power down current	A Port or B Port V_I = V_{CC}	Floating(5)	0V - 5.5V	0.26		1.55	µA
			0V - 5.5V	Floating(5)	0.26		1.55	

ADVANCE INFORMATION

over operating free-air temperature range (unless otherwise noted)[1] [2]

PARAMETER		TEST CONDITIONS	V_{CCA}	V_{CCB}	Operating free-air temperature (T_A) –40°C to 125°C			UNIT
					MIN	TYP	MAX	
C_i	Control Input Capacitance	V_I = 3.3V or V_{GNDA}	3.3V	3.3V			2	pF
C_{io}	Data I/O Capacitance	V_O = 1.71V DC +1MHz -16dBm sine wave	3.3V	3.3V	1.3		2.6	pF
C_{GND}	Cap between grounds	All channels combined (V_{CC} both sides are powered on)					46	pF
		All channels combined (V_{CC} to GND shorted)					53	pF
Leakage	Current Leakage between GndA to GndB	All channels combined (V_{CC} both sides are powered on and inputs are all low)	1.71V – 5.5V	1.71V – 5.5V			1.8	µA
		All channels combined (V_{CC} both sides are powered on and inputs are all high)	1.71V – 5.5V	1.71V – 5.5V			32	µA
		All channels combined (V_{CC} to GND shorted)	1.71V – 5.5V	1.71V – 5.5V			1.8	µA
CMTI	Common Mode Transient Immunity	Input toggling at 100Mbps Ground shift up to 80V	1.71V – 5.5V	1.71V – 5.5V		250		V/µs
TXG8021								
I_{CCA}	V_{CCA} supply current	V_I = V_{CCI} or GND I_O = 0	1.71V – 5.5V	1.71V – 5.5V	300		747	µA
			0V	5.5V	-2		12.5	
			5.5V	0V	349		589	
		V_I = GND I_O = 0	5.5V	Floating[5]	347		577	
I_{CCB}	V_{CCB} supply current	V_I = V_{CCI} or GND I_O = 0	1.71V – 5.5V	1.71V – 5.5V	497		1077	µA
			0V	5.5V	546		919	
			5.5V	0V	-2		24.5	
		V_I = GND I_O = 0	Floating[5]	5.5V	548		919	

ADVANCE INFORMATION

over operating free-air temperature range (unless otherwise noted)[1] [2]

PARAMETER		TEST CONDITIONS	V_{CCA}	V_{CCB}	Operating free-air temperature (T_A) –40°C to 125°C MIN	TYP	MAX	UNIT
I_{CCA} + I_{CCB}	Supply Current - DC Signal	V_I = V_{CCI}	1.8V	1.8V	0.7		1.6	mA
			2.5V	2.5V	0.8		1.6	
			3.3V	3.3V	0.8		1.7	
			5V	5V	0.8		1.9	
		V_I = GND	1.8V	1.8V	0.7		1.6	mA
			2.5V	2.5V	0.8		1.6	
			3.3V	3.3V	0.8		1.7	
			5V	5V	0.8		1.9	
I_{CCA} + I_{CCB}	Supply Current - AC Signal	All channels switching with square wave clock input; CL = 15pF, 1Mbps	1.8V	1.8V	0.9		1.6	mA
			2.5V	2.5V	0.9		1.6	
			3.3V	3.3V	0.9		1.7	
			5V	5V	1.1		2	
		All channels switching with square wave clock input; CL = 15pF, 50Mbps	1.8V	1.8V	4.6		6.3	mA
			2.5V	2.5V	5.5		7.3	
			3.3V	3.3V	6.8		8.2	
			5V	5V	8.7		10.7	
		All channels switching with square wave clock input; CL = 15pF, 100Mbps	1.8V	1.8V	8.5		10.6	mA
			2.5V	2.5V	10		13	
			3.3V	3.3V	12		14.7	
			5V	5V	16.6		20.2	
TXG8020								
I_{CCA}	V_{CCA} supply current	V_I = V_{CCI} or GND I_O = 0	1.71V – 5.5V	1.71V – 5.5V	299		602	µA
			0V	5.5V	-2.5		1.2	µA
			5.5V	0V	302		602	µA
		V_I = GND I_O = 0	5.5V	Floating[5]	299		577	µA
I_{CCB}	V_{CCB} supply current	V_I = V_{CCI} or GND I_O = 0	1.71V – 5.5V	1.71V – 5.5V	504		1225	µA
			0V	5.5V	486		906	µA
			5.5V	0V	-2		24.5	µA
		V_I = GND I_O = 0	Floating[5]	5.5V	486		906	µA

ADVANCE INFORMATION

over operating free-air temperature range (unless otherwise noted)(1) (2)

PARAMETER		TEST CONDITIONS	V_{CCA}	V_{CCB}	Operating free-air temperature (T_A)			UNIT
					–40°C to 125°C			
					MIN	TYP	MAX	
I_{CCA} + I_{CCB}	Supply Current - DC Signal	V_I = V_{CCI}	1.8V	1.8V	0.7		1.6	mA
			2.5V	2.5V	0.8		1.6	mA
			3.3V	3.3V	0.8		1.7	mA
			5V	5V	0.8		1.9	mA
		V_I = GND	1.8V	1.8V	0.7		1.6	mA
			2.5V	2.5V	0.8		1.6	mA
			3.3V	3.3V	0.8		1.7	mA
			5V	5V	0.8		1.9	mA
I_{CCA} + I_{CCB}	Supply Current - AC Signal	All channels switching with square wave clock input; CL = 15pF, 1Mbps	1.8V	1.8V	0.9		1.6	mA
			2.5V	2.5V	0.9		1.6	mA
			3.3V	3.3V	0.9		1.7	mA
			5V	5V	1.1		2	mA
		All channels switching with square wave clock input; CL = 15pF, 50Mbps	1.8V	1.8V	4.5		6.3	mA
			2.5V	2.5V	5.5		7.3	mA
			3.3V	3.3V	6.3		8	mA
			5V	5V	8.4		10.7	mA
		All channels switching with square wave clock input; CL = 15pF, 100Mbps	1.8V	1.8V	8.5		10.7	mA
			2.5V	2.5V	10		13	mA
			3.3V	3.3V	12		14.7	mA
			5V	5V	16.6		20.2	mA
V_{UVLO+}	Positive-Going Undervoltage Lockout Voltage	A Supply	1.71V – 5.5V				1.61	V
		B Supply		1.71V – 5.5V			1.61	V
V_{UVLO-}	Negative-Going Undervoltage Lockout Voltage	A Supply	1.71V – 5.5V		1.33			V
		B Supply		1.71V – 5.5V	1.33			V
V_{UVLO_Hys}	Undervoltage Lockout Hysteresis	A Supply	1.71V – 5.5V		0.12	0.15		V
		B Supply		1.71V – 5.5V	0.12	0.15		V

(1) V_{CCI} is the V_{CC} associated with the input port and referenced to GND_A
(2) V_{CCO} is the V_{CC} associated with the output port and referenced to GND_B
(3) Tested at V_I = $V_{T+(MAX)}$
(4) Tested at V_I = $V_{T-(MIN)}$

ADVANCE INFORMATION

(5) Floating is defined as a node that is both not actively driven by an external device and has leakage not exeeding 10nA

5.5 Switching Characteristics, V_{CCA} = 1.8 ± 0.15V

PARAMETER		TEST CONDITIONS	FROM	TO	TEMPERATURE	B-Port Supply Voltage (V_{CCB})									UNIT
						1.8 ± 0.15V			2.5 ± 0.2V			3.3 ± 0.3V			5.0 ± 0.5V			
						MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
t_{pd}	Propagation delay	1Mbps all 4 channels toggling	A	B	-40°C to 85°C	2.8		7.3	2.8		7.4	2.8		7.5	2.9		7.8	ns
			A	B	-40°C to 125°C	2.8		7.6	2.8		7.8	2.8		7.9	2.9		8.3	
			B	A	-40°C to 85°C	2.8		7.3	2.7		5.7	2.6		5.1	2.6		4.8	
			B	A	-40°C to 125°C	2.8		7.7	2.7		6	2.6		5.3	2.6		5.1	
PWD	Pulse width distortion	$\lvert t_{phl} - t_{plh} \rvert$	A	B	-40°C to 85°C	0.7		1.5	0.6		1.5	0.5		1.4	0.5		1.2	ns
			A	B	-40°C to 125°C	0.7		1.5	0.6		1.5	0.5		1.4	0.5		1.2	
			B	A	-40°C to 85°C	0.7		1.5	0.6		1.5	0.5		1.4	0.5		1.2	
			B	A	-40°C to 125°C	0.7		1.5	0.6		1.5	0.5		1.4	0.4		1.2	
t_r	Output signal rise time		A	B	-40°C to 85°C	0.5		1.3	0.5		1.35	0.5		1.4	0.5		1.6	ns
			A	B	-40°C to 125°C	0.5		1.3	0.5		1.4	0.5		1.4	0.5		1.7	
			B	A	-40°C to 85°C	0.5		1.2	0.5		1.3	0.5		1.2	0.5		1.3	
			B	A	-40°C to 125°C	0.5		1.3	0.5		1.4	0.5		1.3	0.5		1.3	
tf	Output signal fall time		A	B	-40°C to 85°C	0.4		1.3	0.4		1.3	0.4		1.5	0.5		1.7	ns
			A	B	-40°C to 125°C	0.4		1.5	0.4		1.5	0.4		1.6	0.5		2	
			B	A	-40°C to 85°C	0.4		1.3	0.4		1.4	0.4		1.3	0.4		1.3	
			B	A	-40°C to 125°C	0.4		1.4	0.4		1.45	0.4		1.4	0.4		1.35	
t_{DO}	Default output delay time from input power loss	Measured from the time V_{CC} goes below 1.36V			-40°C to 85°C	6.1		10.6	6.1		10.4	6		10.3	5.9		9.9	µs
					-40°C to 125°C	6.1		10.6	6.1		10.4	6		10.3	5.9		9.9	
t_{PU}	Time from ULVO to valid output data				-40°C to 85°C	21.1		64.3	4.3		69.1	4.5		76.6	55.3		99.4	µs
					-40°C to 125°C	19.9		64.3	4.3		69.1	4.5		76.6	53.9		99.4	

ADVANCE INFORMATION

5.6 Switching Characteristics, V_{CCA} = 2.5 ± 0.2V

PARAMETER		TEST CONDITIONS	FROM	TO	TEMPERATURE	B-Port Supply Voltage (V_{CCB})												UNIT
						1.8 ± 0.15V			2.5 ± 0.2V			3.3 ± 0.3V			5.0 ± 0.5V			
						MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
t_{pd}	Propagation delay	1Mbps all 4 channels toggling	A	B	-40°C to 85°C	2.7		5.7	2.7		5.8	2.7		5.9	2.8		6.3	ns
			A	B	-40°C to 125°C	2.7		6	2.7		6.1	2.7		6.2	2.8		6.6	
			B	A	-40°C to 85°C	2.8		7.4	2.7		5.8	2.6		5.1	2.6		4.9	
			B	A	-40°C to 125°C	2.8		7.7	2.7		6.1	2.6		5.5	2.6		5.2	
PWD	Pulse width distortion	$\lvert t_{phl} - t_{plh} \rvert$	A	B	-40°C to 85°C	0.1		1	0.1		0.8	0		0.7	-0.14		0.6	ns
			A	B	-40°C to 125°C	0.1		1	0.1		0.8	0		0.7	-0.15		0.6	
			B	A	-40°C to 85°C	0.1		1	0.1		0.8	0		0.7	-0.14		0.6	
			B	A	-40°C to 125°C	0.1		1	0.1		0.8	0		0.7	-0.15		0.6	
t_r	Output signal rise time		A	B	-40°C to 85°C	0.5		1.3	0.5		1.3	0.5		1.4	0.5		1.6	ns
			A	B	-40°C to 125°C	0.5		1.3	0.5		1.4	0.5		1.4	0.5		1.7	
			B	A	-40°C to 85°C	0.5		1.3	0.4		1.3	0.5		1.3	0.4		1.3	
			B	A	-40°C to 125°C	0.5		1.3	0.4		1.3	0.5		1.3	0.4		1.4	
tf	Output signal fall time		A	B	-40°C to 85°C	0.4		1.4	0.4		1.3	0.4		1.5	0.5		1.7	ns
			A	B	-40°C to 125°C	0.4		1.4	0.4		1.5	0.4		1.6	0.5		2	
			B	A	-40°C to 85°C	0.4		1.3	0.4		1.3	0.4		1.35	0.4		1.3	
			B	A	-40°C to 125°C	0.4		1.5	0.4		1.5	0.4		1.4	0.4		1.5	
t_{DO}	Default output delay time from input power loss	Measured from the time V_{CC} goes below 1.36V			-40°C to 85°C	6.1		10.6	6.1		10.4	5.6		10.4	5.4		9.9	µs
					-40°C to 125°C	6.1		10.6	6.1		10.4	5.6		10.4	5.4		9.9	
t_{PU}	Time from ULVO to valid output data				-40°C to 85°C	21.1		64.3	4.3		69.1	4.5		76.6	55.3		99.4	µs
					-40°C to 125°C	19.9		64.3	4.3		69.1	4.5		76.6	53.9		99.4	

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5.7 Switching Characteristics, V_{CCA} = 3.3 ± 0.3V

PARAMETER		TEST CONDITIONS	FROM	TO	TEMPERATURE	B-Port Supply Voltage (V_{CCB})												UNIT
						1.8 ± 0.15V			2.5 ± 0.2V			3.3 ± 0.3V			5.0 ± 0.5V			
						MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
t_{pd}	Propagation delay	1Mbps all 4 channels toggling	A	B	-40°C to 85°C	2.6		5.1	2.7		5.2	2.7		5.3	2.8		5.8	ns
			A	B	-40°C to 125°C	2.6		5.3	2.7		5.5	2.7		5.7	2.8		6.3	
			B	A	-40°C to 85°C	2.8		7.5	2.7		5.9	2.7		5.3	2.6		5.1	
			B	A	-40°C to 125°C	2.8		7.9	2.7		6.2	2.7		5.7	2.6		5.4	
PWD	Pulse width distortion	$\lvert t_{phl} - t_{plh} \rvert$	A	B	-40°C to 85°C	-0.03		0.6	-0.09		0.5	-0.13		0.5	-0.3		0.4	ns
			A	B	-40°C to 125°C	-0.11		0.6	-0.13		0.5	-0.18		0.5	-0.4		0.4	
			B	A	-40°C to 85°C	-0.03		0.6	-0.09		0.5	-0.13		0.5	-0.3		0.4	
			B	A	-40°C to 125°C	-0.11		0.6	-0.13		0.5	-0.18		0.5	-0.4		0.4	
t_r	Output signal rise time		A	B	-40°C to 85°C	0.5		1.3	0.5		1.3	0.5		1.4	0.5		1.6	ns
			A	B	-40°C to 125°C	0.5		1.3	0.5		1.4	0.5		1.4	0.5		1.6	
			B	A	-40°C to 85°C	0.5		1.3	0.5		1.3	0.5		1.4	0.5		1.4	
			B	A	-40°C to 125°C	0.5		1.35	0.5		1.4	0.5		1.4	0.5		1.5	
tf	Output signal fall time		A	B	-40°C to 85°C	0.4		1.3	0.4		1.4	0.4		1.5	0.5		1.7	ns
			A	B	-40°C to 125°C	0.4		1.5	0.4		1.6	0.4		1.6	0.5		2	
			B	A	-40°C to 85°C	0.4		1.4	0.4		1.4	0.4		1.4	0.4		1.4	
			B	A	-40°C to 125°C	0.4		1.7	0.4		1.6	0.4		1.6	0.4		1.7	
t_{DO}	Default output delay time from input power loss	Measured from the time V_{CC} goes below 1.36V			-40°C to 85°C	6		10.6	5.8		10.4	5.8		10.3	5.8		10	µs
					-40°C to 125°C	6		10.6	5.8		10.4	5.8		10.3	5.8		10	µs
t_{PU}	Time from ULVO to valid output data				-40°C to 85°C	21.1		64.3	4.3		69.1	4.5		76.6	57.8		99.4	µs
					-40°C to 125°C	19.9		64.3	4.3		69.1	4.5		76.6	53.9		99.4	µs

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5.8 Switching Characteristics, V_{CCA} = 5.0 ± 0.5V

PARAMETER		TEST CONDITIONS	FROM	TO	TEMPERATURE	B-Port Supply Voltage (V_{CCB})												UNIT
						1.8 ± 0.15V			2.5 ± 0.2V			3.3 ± 0.3V			5.0 ± 0.5V			
						MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
t_{pd}	Propagation delay	1Mbps all 4 channels toggling	A	B	-40°C to 85°C	2.6		4.8	2.6		5	2.7		5.1	2.8		5.6	ns
			A	B	-40°C to 125°C	2.6		5.1	2.6		5.3	2.7		5.4	2.8		5.9	
			B	A	-40°C to 85°C	3		7.9	2.8		6.2	2.7		5.9	2.7		5.6	
			B	A	-40°C to 125°C	3		8.4	2.8		6.6	2.7		6.2	2.7		6	
PWD	Pulse width distortion	$\lvert t_{phl} - t_{plh} \rvert$	A	B	-40°C to 85°C	-0.22		0.4	-0.27		0.3	-0.32		0.3	-0.50		0.2	ns
			A	B	-40°C to 125°C	-0.33		0.4	-0.37		0.3	-0.42		0.3	-0.60		0.2	
			B	A	-40°C to 85°C	-0.22		0.4	-0.27		0.3	-0.32		0.3	-0.5		0.2	
			B	A	-40°C to 125°C	-0.33		0.4	-0.37		0.3	-0.42		0.3	-0.60		0.2	
t_r	Output signal rise time		A	B	-40°C to 85°C	0.5		1.3	0.5		1.3	0.5		1.4	0.5		1.6	ns
			A	B	-40°C to 125°C	0.5		1.3	0.5		1.4	0.5		1.4	0.5		1.6	
			B	A	-40°C to 85°C	0.6		1.6	0.6		1.6	0.6		1.6	0.5		1.6	
			B	A	-40°C to 125°C	0.6		1.75	0.6		1.7	0.6		1.7	0.5		1.6	
tf	Output signal fall time		A	B	-40°C to 85°C	0.4		1.3	0.4		1.4	0.4		1.5	0.5		1.7	ns
			A	B	-40°C to 125°C	0.4		1.4	0.4		1.5	0.4		1.6	0.5		2	
			B	A	-40°C to 85°C	0.4		1.8	0.5		1.8	0.4		1.8	0.4		1.8	
			B	A	-40°C to 125°C	0.4		2.5	0.5		2	0.4		2	0.4		2	
t_{DO}	Default output delay time from input power loss	Measured from the time V_{CC} goes below 1.36V			-40°C to 85°C	5.5		10.7	5.6		10.5	5.7		10.6	5.9		10	µs
					-40°C to 125°C	5.5		10.7	5.6		10.5	5.7		10.6	5.9		10	
t_{PU}	Time from ULVO to valid output data				-40°C to 85°C	21.1		64.3	4.3		69.1	4.5		76.6	55.3		99.4	µs
					-40°C to 125°C	19.9		64.3	4.3		69.1	4.5		76.6	53.9		99.4	

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5.9 Switching Characteristics: T_{sk}, T_{MAX}

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		V_{CCI}	V_{CCO}	Operating free-air temperature (T_A) -40°C to 125°C MIN	TYP	MAX	UNIT
T_{MAX} - Maximum Data Rate	50% Duty Cycle Input One channel switching 20% of pulse > 0.7*V_{CCO} 20% of pulse < 0.3*V_{CCO}	No Translation	1.65V - 1.95V	1.65V - 1.95V	264			Mbps
			2.3V - 2.7V	2.3V - 2.7V	220			
			3.0V - 3.6V	3.0V - 3.6V	220			
			4.5V - 5.5V	4.5V - 5.5V	176			
T_{MAX} - Maximum Data Rate	50% Duty Cycle Input One channel switching 20% of pulse > 0.7*V_{CCO} 20% of pulse < 0.3*V_{CCO}	Up Translation	1.65V - 1.95V	2.3V - 2.7V	264			Mbps
			1.65V - 1.95V	3.0V - 3.6V	264			
			1.65V - 1.95V	4.5V - 5.5V	264			
			2.3V - 2.7V	3.0V - 3.6V	220			
			2.3V - 2.7V	4.5V - 5.5V	220			
			3.0V - 3.6V	4.5V - 5.5V	176			
T_{MAX} - Maximum Data Rate	50% Duty Cycle Input One channel switching 20% of pulse > 0.7*V_{CCO} 20% of pulse < 0.3*V_{CCO}	Down Translation	2.3V - 2.7V	1.65V - 1.95V	264			Mbps
			3.0V - 3.6V	2.3V - 2.7V	220			
			3.0V - 3.6V	1.65V - 1.95V	220			
			4.5V - 5.5V	3.0V - 3.6V	176			
			4.5 V - 5.5 V	1.65 V - 1.95 V	220			
			4.5V - 5.5V	1.65V - 1.95V	220			
t_{sk} - Output skew	Timing skew between any switching outputs on the rising or falling edge (same direction channels)	No Translation	1.65V - 1.95V	1.65V - 1.95V			0.02	ns
			2.3V - 2.7V	2.3V - 2.7V			0.02	
			3.0V - 3.6V	3.0V - 3.6V			0.02	
			4.5V - 5.5V	4.5V - 5.5V			0.04	
t_{sk} - Output skew	Timing skew between any switching outputs on the rising or falling edge (same direction channels)	Up Translation	1.65V - 1.95V	2.3V - 2.7V			0.02	ns
			1.65V - 1.95V	3.0V - 3.6V			0.02	
			1.65V - 1.95V	4.5V - 5.5V			0.02	
			2.3V - 2.7V	3.0V - 3.6V			0.02	
			2.3V - 2.7V	4.5V - 5.5V			0.02	
			3.0V - 3.6V	4.5V - 5.5V			0.02	

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over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		V_{CCI}	V_{CCO}	Operating free-air temperature (T_A)			UNIT
					-40°C to 125°C			
					MIN	TYP	MAX	
t_{sk} - Output skew	Timing skew between any switching outputs on the rising or falling edge (same direction channels)	Down Translation	2.3V - 2.7V	1.65 V - 1.95 V			0.02	ns
			3.0V - 3.6V	2.3V - 2.7V			0.02	
			3.0V - 3.6V	1.65V - 1.95V			0.02	
			4.5V - 5.5V	3.0V - 3.6V			0.04	
			4.5V - 5.5V	2.3V - 2.7V			0.04	
			4.5V - 5.5V	1.65V - 1.95V			0.04	

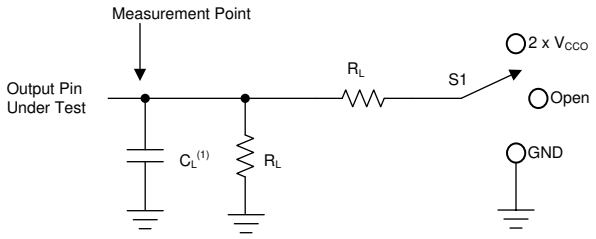
ADVANCE INFORMATION

6 Parameter Measurement Information

6.1 Load Circuit and Voltage Waveforms

Unless otherwise noted, generators supply all input pulses that have the following characteristics:

- f = 1MHz
- Z_O = 50Ω
- Δt/ΔV ≤ 1ns/V

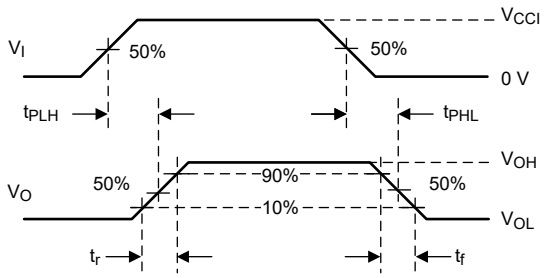


A. C_L includes probe and jig capacitance.

Figure 6-1. Load Circuit

Table 6-1. Load Circuit Conditions

Parameter	V_{CCO}	R_L	C_L	S_1	V_{TP}
t_{pd} Propagation (delay) time	1.71V – 5.5V	10kΩ	15pF	Open	N/A



1. V_{CCI} is the supply pin associated with the input port.
2. V_{OH} and V_{OL} are typical output voltage levels that occur with specified R_L, C_L, and S_1

Figure 6-2. Switching Characteristics Voltage Waveforms

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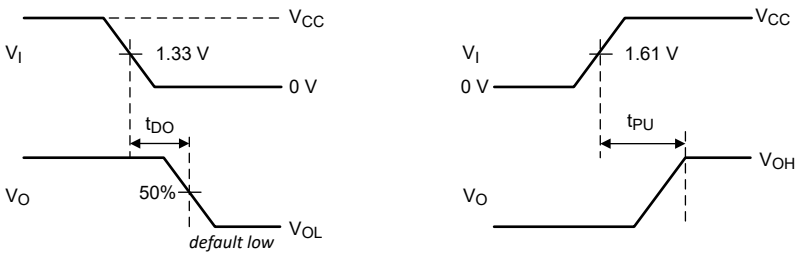
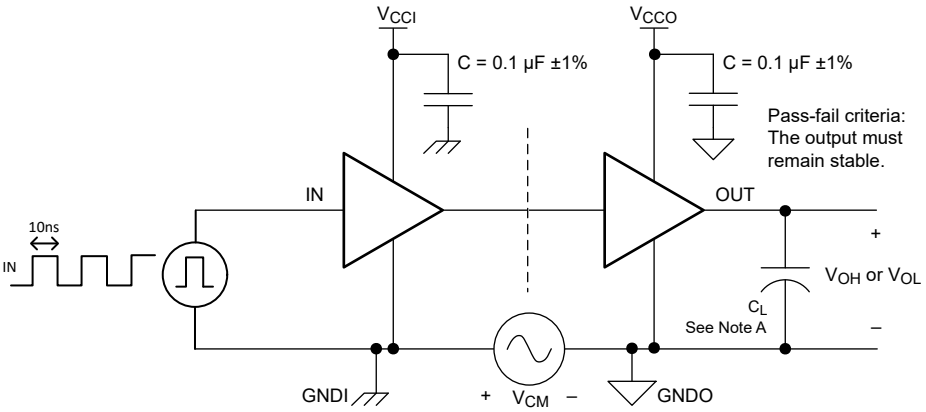


1. V_{CCI} is the supply pin associated with the input port.
2. V_{OH} and V_{OL} are typical output voltage levels that occur with specified R_L, C_L, and S_1

Figure 6-3. Default Output Delay Time & Time from UVLO to Valid Output Voltage Waveform



1. C_L = 15pF and includes instrumentation and fixture capacitance within ±20%.

Figure 6-4. Common-Mode Transient Immunity Test Circuit

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7 Detailed Description

7.1 Overview

The TXG802x-Q1 is a 2-bit ground-level translator that uses two individually configurable power-supply rails which allows it to translate across two different power domains. The device is operational with V_{CCA} and V_{CCB} supplies as low as 1.71V and as high as 5.5V. The A port is designed to track V_{CCA} and the B port is designed to track V_{CCB}. In addition to I/O level shifting, this translator can support a difference of -80V to +80V between GNDA and GNDB. V_{CCA} is referenced to GNDA and V_{CCB} is referenced to GNDB.

The TXG802x-Q1 device is designed for asynchronous communication between data buses, and transmits data with fixed direction from the A bus to the B bus on some channels and from the B bus to the A bus on the remaining channels.

The V_{CC} disconnect feature ensures that if V_{CC} is disconnected with the complementary supply within recommended operating conditions, outputs are disabled and set to the high-impedance state while the supply current is maintained. The $I_{off-float}$ circuitry ensures that no excessive current is drawn from or sourced into an input or output while the supply is floating.

Glitch-free power supply sequencing allows either supply rail to be powered on or off in any order while providing robust power sequencing performance.

7.2 Functional Block Diagram

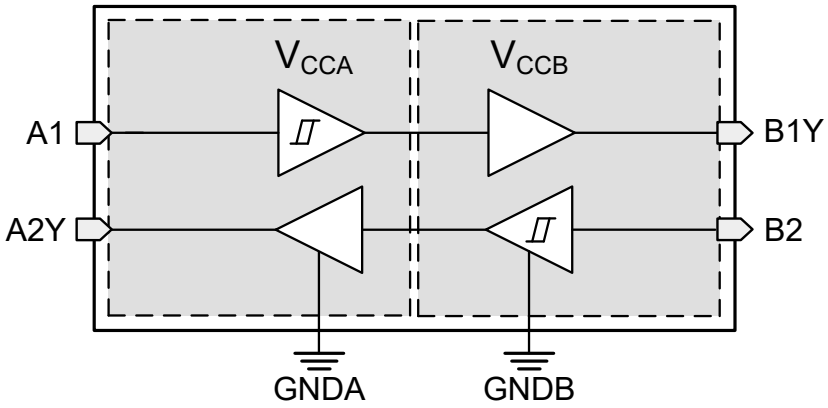

Figure 7-1. TXG8021-Q1 Functional Block Diagram

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7.3 Feature Description

7.3.1 CMOS Schmitt-Trigger Inputs with Integrated Pulldowns

Standard CMOS inputs are high impedance and are typically modeled as a resistor in parallel with the input capacitance given in the *Section 5.4*. The worst case resistance is calculated with the maximum input voltage, given in the *Section 5.1*, and the maximum input leakage current, given in the *Section 5.4*, using ohm's law (R = V ÷ I).

The Schmitt-trigger input architecture provides hysteresis as defined by ΔV_T in the *Section 5.4*, which makes this device extremely tolerant to slow or noisy inputs. Driving the inputs slowly will increase dynamic current consumption of the device. See *Understanding Schmitt Triggers* for additional information regarding Schmitt-trigger inputs.

7.3.1.1 Inputs with Integrated Static Pull-Down Resistors

This device has 5MΩ typical integrated weak pull-downs for each input. This feature allows all inputs to be left floating without the concern for unstable outputs or increased current consumption. This also helps to reduce external component count for applications where not all channels are used or need to be fixed low. If an external pull-up is required, it should be no larger than 1MΩ to avoid contention with the 5MΩ internal pull-down.

7.3.2 Balanced High-Drive CMOS Push-Pull Outputs

A balanced output allows the device to sink and source similar currents. The high drive capability of this device creates fast edges into light loads, so routing and load conditions should be considered to prevent ringing. Additionally, the outputs of this device are capable of driving larger currents than the device can sustain without being damaged. *Section 5.1* defines the electrical and thermal limits that must be followed at all times.

7.3.3 V_{CC} Disconnect

The outputs for this device are disabled and enter a high-impedance state when either supply is left floating (disconnected), and with the complementary supply within recommended operating conditions. It is recommended that the inputs are kept low before floating (disconnecting) either supply.

The $I_{CCx(floating)}$ in the *Section 5.4* specifies the maximum supply current. The $I_{off(float)}$ in the *Section 5.4* specifies the maximum leakage into or out of any input or output pin on the device.

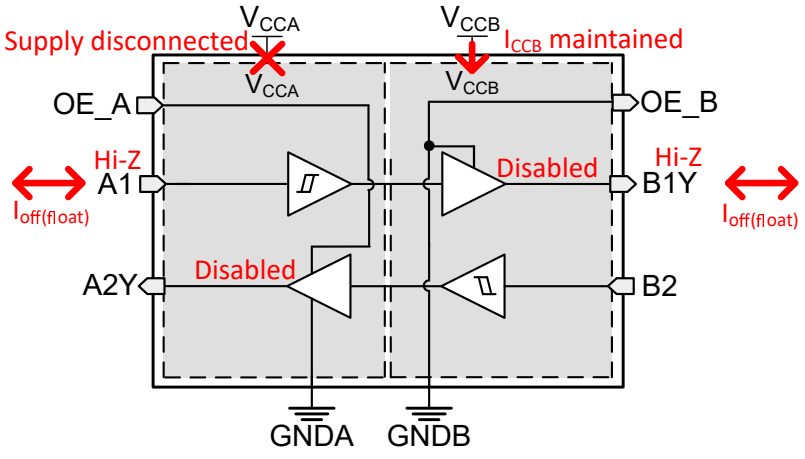


Figure 7-2. V_{CC} Disconnect Feature

7.3.4 Over-Voltage Tolerant Inputs

Input signals to this device can be driven above the supply voltage so long as they remain below the maximum input voltage value specified in the *Section 5.3*.

7.3.5 Glitch-Free Power Supply Sequencing

Either supply rail may be powered on or off in any order without producing a glitch on the inputs or outputs (that is, where the output erroneously transitions to V_{CC} when it should be held low or vice versa). Glitches of this nature can be misinterpreted by a peripheral as a valid data bit, which could trigger a false device reset of the peripheral, a false device configuration of the peripheral, or even a false data initialization by the peripheral.

7.3.6 Negative Clamping Diodes

Figure 7-3 depicts the inputs and outputs to this device that have negative clamping diodes.

CAUTION

Voltages beyond the values specified in the Section 5.1 table can cause damage to the device. The input negative-voltage and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

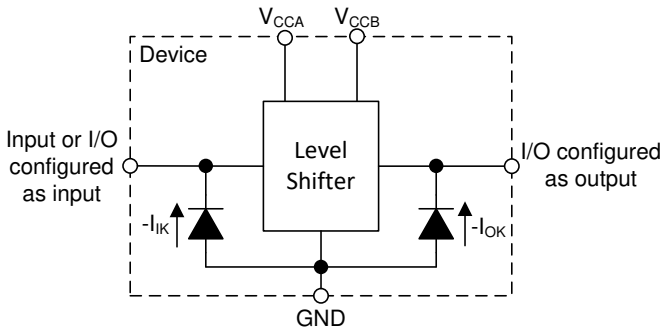


Figure 7-3. Electrical Placement of Clamping Diodes for Each Input and Output

7.3.7 Fully Configurable Dual-Rail Design

The V_{CCA} and V_{CCB} pins can be supplied at any voltage from 1.71V to 5.5V, making the device suitable for translating between any of the voltage nodes (1.8V, 2.5V, 3.3V, and 5.0V).

7.3.8 Supports High-Speed Translation

The TXG802x-Q1 device can support high data-rate applications. The translated signal data rate can be greater than 250Mbps when the signal is translated from 1.71V to 5.5V.

ADVANCE INFORMATION

7.3.9 AC Noise Rejection

TXG802x-Q1 supports I/O voltage translation in environments with noisy grounds. The plot below illustrates the amount of noise that GNDA and GNDB can reject in terms peak-to-peak voltage over frequency without disrupting communication between two systems. As an example, Figure 7-5 below shows GNDA with a ground bounce of $2V_{PP}$ at 10kHz but still effectively translating 5V to 2.5V without any degradation.

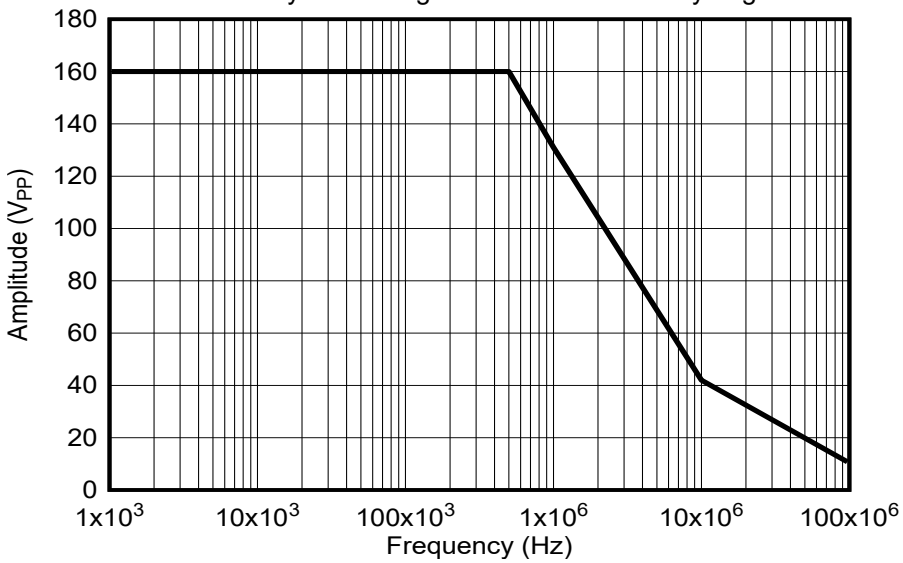
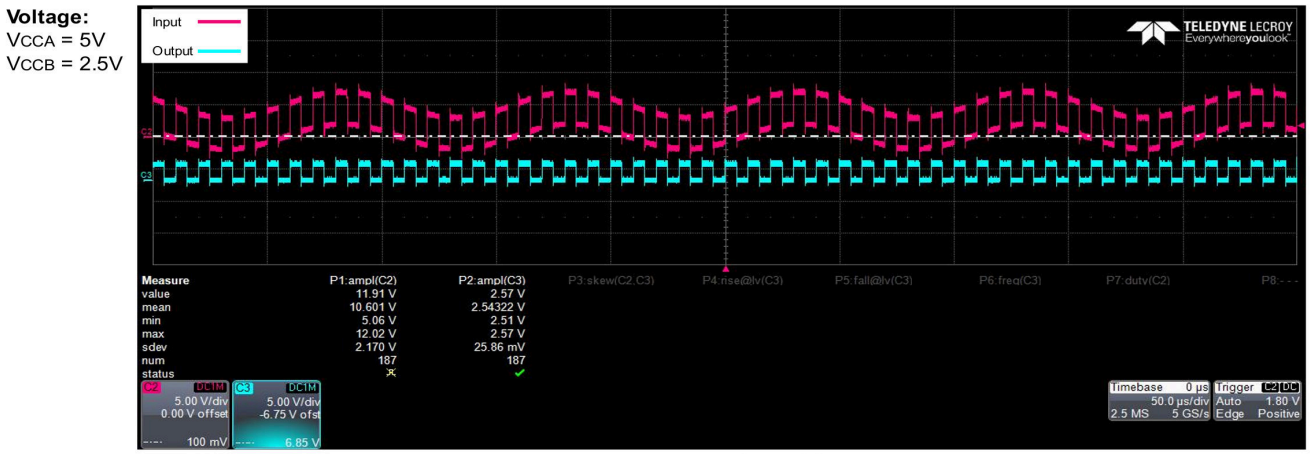


Figure 7-4. AC Noise Rejection Plot



*Note: Offset voltage on the output to show both signals side-by-side

Figure 7-5. Waveform showing 5V to 2.5V I/O translation with AC Ground Noise of $2V_{PP}$ at 10kHz

7.4 Device Functional Modes

Table 7-1. Function Table

Power Supply		Port Status	
VCCI	VCCO	Input	Output
PU	PU	H	H
PU	PU	L	L
PU	PU	X	Hi-Z
PU	PU	Open	L
PD	PU	X	L
X	PU	X	High-Z
X	PU	X	L
X	PD	X	Undetermined

1. In the table above: PU = Powered Up; PD = Powered Down; X = Irrelevant; H = High Level; L = Low Level; Open = Floating

ADVANCE INFORMATION

8 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Application Information

The TXG802x-Q1 is used for level translation, enabling communication between devices or systems operating at different interface and ground voltages. The TXG802x-Q1 device is ideal for use in applications where a push-pull driver is connected to the data inputs. Figure 8-1 is an example of two systems that translate from 1.8V to 3.3V while also experiencing a ground shift of 5V. The ground shift occurs due to the parasitic resistance of the cable used to connect the 48V battery ground and 12V battery ground to the chassis of the car.

8.2 Typical Application

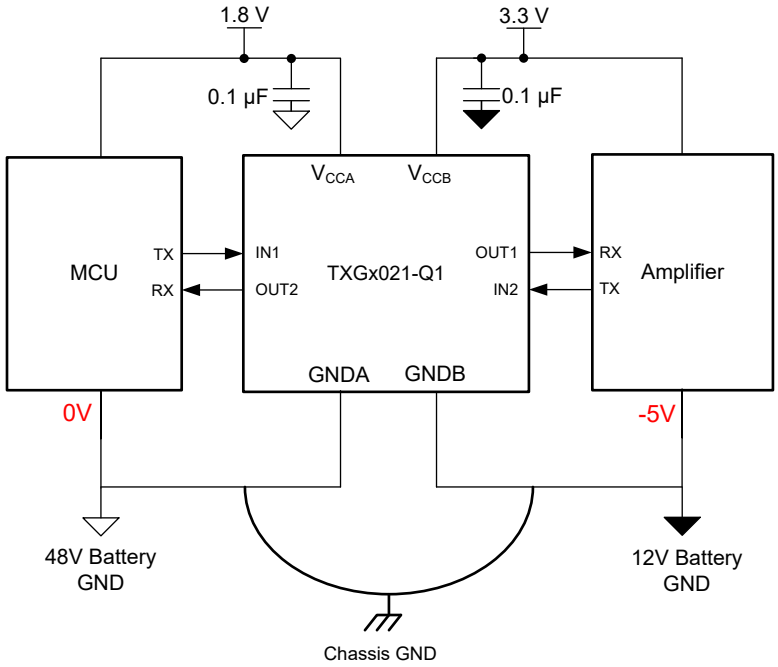


Figure 8-1. TXG8021-Q1 in Automotive

8.2.1 Design Requirements

Use the parameters listed in Table 8-1 for this design example.

Table 8-1. Design Parameters

DESIGN PARAMETERS	EXAMPLE VALUES
Input voltage range	1.71V to 5.5V
Output voltage range	1.71V to 5.5V

8.2.2 Detailed Design Procedure

To begin the design process, determine the following:

- Input voltage range

  - Use the supply voltage of the device that is driving the TXG802x-Q1 device to determine the input voltage range. For a valid logic-high, the value must exceed the positive-going input-threshold voltage (V_{T+}) of the input port. For a valid logic low the value must be less than the negative-going input-threshold voltage (V_{T-}) of the input port.
- Output voltage range
  - Use the supply voltage of the device that the TXG802x-Q1 device is driving to determine the output voltage range.

8.2.3 Application Curves

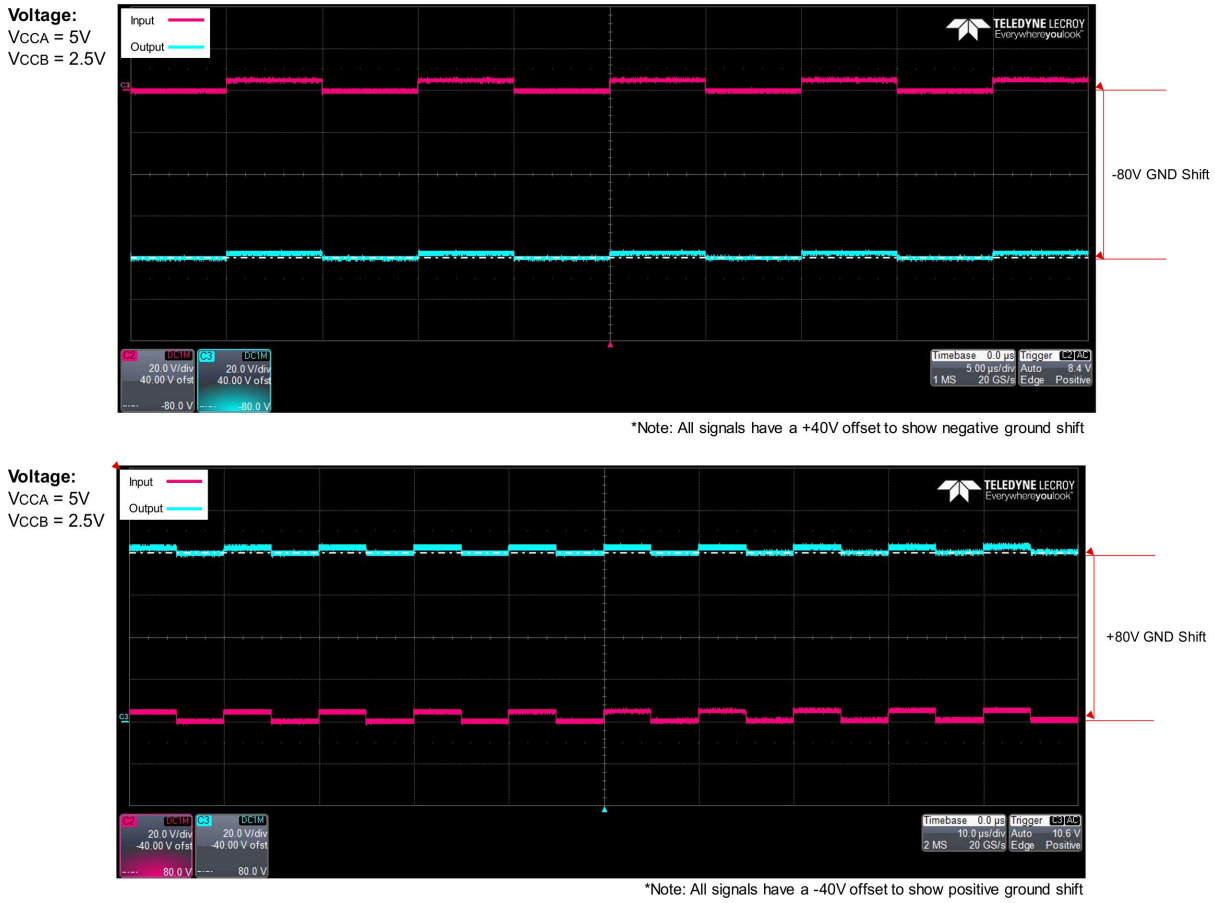


Figure 8-2. Waveform showing -80V (top) and +80V (bottom) Ground Shift with 5V to 2.5V I/O Translation

ADVANCE INFORMATION

8.3 Power Supply Recommendations

Always apply a ground reference to the GND pins first. This device is designed for glitch free power sequencing without any supply sequencing requirements such as ramp order or ramp rate. Please make sure the difference between V_{CC} and GND remains at 6.5V max at all times.

8.4 Layout

8.4.1 Layout Guidelines

To ensure reliability of the device, following common printed-circuit board layout guidelines are recommended:

- Use bypass capacitors on the power supply pins and place them as close to the device as possible. A 0.1µF capacitor is recommended, but transient performance can be improved by having 1µF and 0.1µF capacitors in parallel as bypass capacitors.
- The high drive capability of this device creates fast edges into light loads so routing and load conditions should be considered to prevent ringing.
- A 0.1µF capacitor can be added between GNDA and GNDB to improve performances of CMTI.

8.4.2 Layout Example

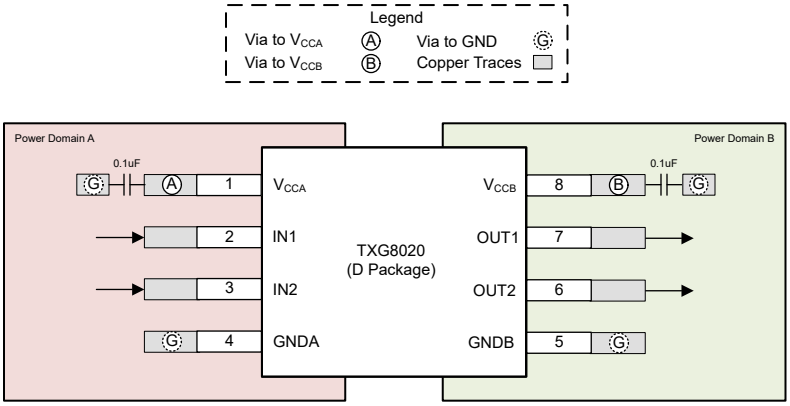


Figure 8-3. D Layout Example

9 Device and Documentation Support

9.1 Device Support

9.1.1 Regulatory Requirements

No statutory or regulatory requirements apply to this device.

There are no special characteristics for this product.

9.2 Documentation Support

9.2.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, *Understanding Schmitt Triggers* application report
- Texas Instruments, *CMOS Power Consumption and C_{pd} Calculation* application report

9.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

9.4 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

9.5 Trademarks

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9.6 Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

9.7 Glossary

TI Glossary — This glossary lists and explains terms, acronyms, and definitions.

10 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

DATE	REVISION	NOTES
May 2025	*	Initial Release

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

ADVANCE INFORMATION

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
PTXG8020QDRQ1	Active	Preproduction	SOIC (D) | 8	3000 | LARGE T&R	-	Call TI	Call TI	-40 to 125	
PTXG8021QDRQ1	Active	Preproduction	SOIC (D) | 8	3000 | LARGE T&R	-	Call TI	Call TI	-40 to 125	

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

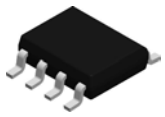
(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

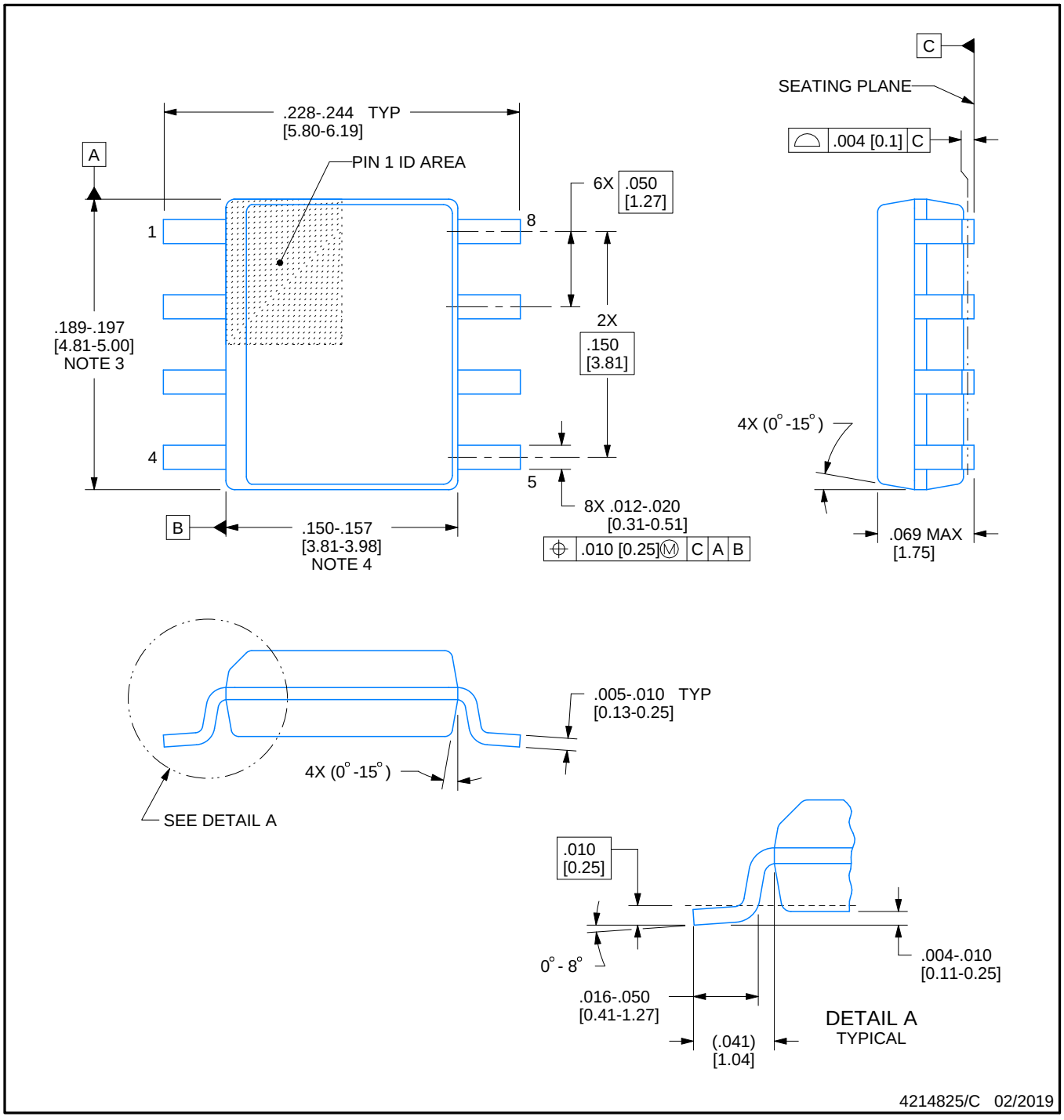


PACKAGE OUTLINE

D0008A

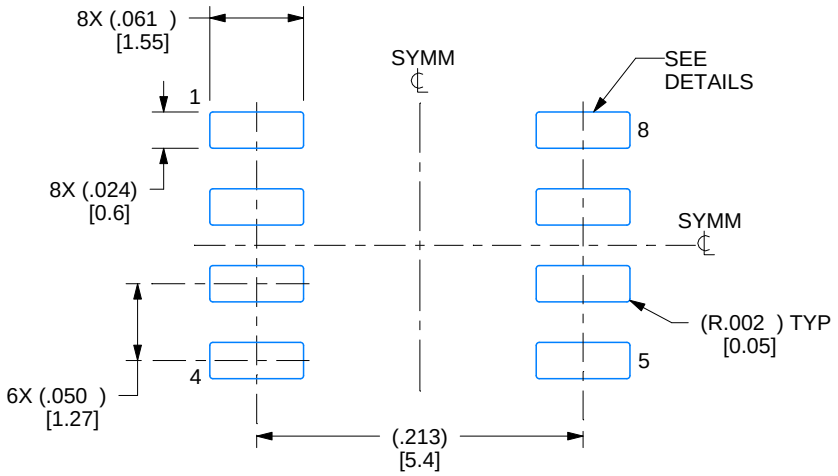
SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT

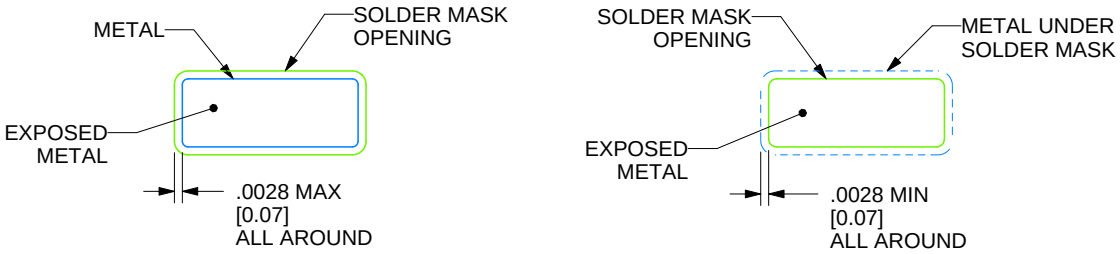


NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:8X



SOLDER MASK DETAILS

4214825/C 02/2019

NOTES: (continued)

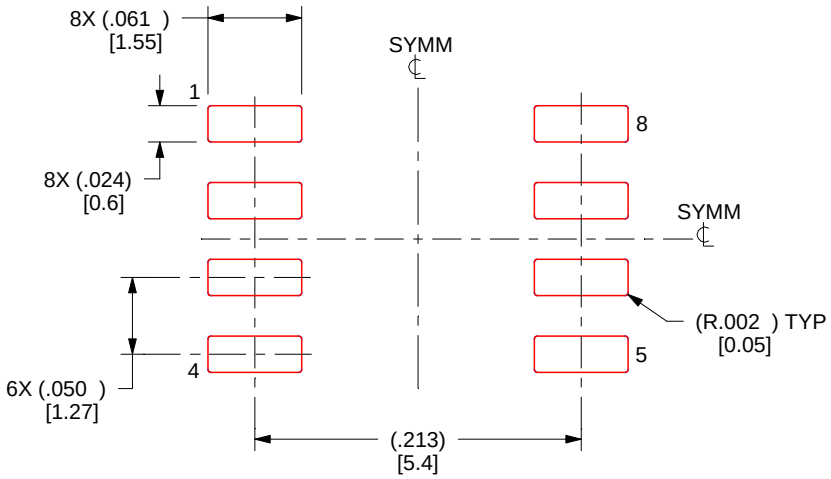
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE
BASED ON .005 INCH [0.125 MM] THICK STENCIL
SCALE:8X

4214825/C 02/2019

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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